

Notice of References Cited	Application/Control No. 10/051,861	Applicant(s)/Patent Under Reexamination LUO ET AL.	
	Examiner Nicholas Martin	Art Unit 2154	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0010865	01-2002	FULTON et al.	709/229
	B	US-2002/0075844	06-2002	Hagen, W. Alexander	370/351
	C	US-6,765,881	07-2004	Rajakarunanayake, Yasantha N.	370/256
	D	US-6,606,744	08-2003	Mikurak, Michael G.	717/174
	E	US-6,016,318	01-2000	Tomoike, Hiroyuki	709/249
	F	US-2002/0069278	06-2002	Forslow, Jan	709/229
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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